Notice of References Cited Application/Control No. 09/903,838 Application/Sontrol No. 09/903,838 Application(s)/Patent Under Reexamination FANGMAN ET AL. Examiner Andrew C. Lee 2419 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0052915	05-2002	Amin-Salehi, Bahman	709/203
*	В	US-6,097,719	08-2000	Benash et al.	370/352
*	C	US-6,772,210	08-2004	Edholm, Philip K.	709/226
*	D	US-7,002,973	02-2006	MeLampy et al.	370/401
*	Е	US-6,798,751	09-2004	Voit et al.	370/252
*	F	US-2002/0044567	04-2002	Voit et al.	370/467
*	G	US-6,980,526	12-2005	Jang et al.	370/260
*	Ι	US-2001/0043571	11-2001	Jang et al.	370/260
*	I	US-6,772,210	08-2004	Edholm, Philip K.	709/226
*	J	US-2002/0093915	07-2002	Larson, Victor	370/235
*	K	US-6,765,881	07-2004	Rajakarunanayake, Yasantha N.	370/256
*	L	US-6,529,499	03-2003	Doshi et al.	370/352
*	М	US-6,097,719	08-2000	Benash et al.	370/352

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	V					
	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.